

<b>Notice of References Cited</b>	Application/Control No. 10/748,463		Applicant(s)/Patent Under Reexamination KWON, WON TAIK	
	Examiner Chandra Chaudhari		Art Unit 2891	Page 1 of 1

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*	C	US-6,136,662	10-2000	Allman et al.	438/427
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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